Docket No.: J&R-0694

MAR 1 0 2006

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March 10, 2006

Date

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applic. No.

09/922,479

Confirmation No: 7212

Applicant Filed

Thomas Zettler

Title

August 3, 2001

Method and Device for Testing an Integrated Circuit, Integrated

Circuit to be Tested, and Wafer with a Large Number of Integrated

Circuits to be Tested

Art Unit

2138

Examiner

Phung M. Chung

Docket No.

J&R-0694

Customer No.

24131

## RESPONSE

Hon. Commissioner for Patents

Sir:

Responsive to the Office Action dated February 13, 2006, the following remarks are made:

In deference to the restriction requirement on page 2 of the above-identified Office Action, applicants elect group I, claims 1 - 4, 6 - 17, 19 - 23 and 29 for prosecution at this time.

In view of the foregoing, the early issuance of an Action on the merits of claims 1 - 4, 6 - 17, 19 - 23 and 29 is solicited.

Respectfully submitted.

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Date: March 10, 2006

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